

**Search Notes**

Application No.

10/001,442

Examiner

Ba Huynh

Applicant(s)

SHELDON ET AL.

Art Unit

2179

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Exam. US Pat, US PGR, EP, JPO, DERVENT, IBM-TSS files searched updated	2/17/05	HY